

Houston LTUF

Owner /Operator Committee

Houston LTUF Owner/Operator Committee

- First meeting held October 6, 2009 at ISA Expo
- Now have:
 - 24 members
 - Representing 16 companies
 - And continuing to grow

Owner/Operator Committee

- Meetings held every 2 months via teleconference:
 - May 25 – SPI-SAP Interface presented by David Land of ConocoPhillips
 - July 27 – Claiming/Merging and Plant/Area/Unit Structure presented by Greg Brueckner of Bayer Technology Services

Owner/Operator Committee

- Meetings held every 2 months via teleconference:
 - September 21 - Instrument Specification Forms with presentations by:
 - Rick Graham of ExxonMobile
 - Bret Fisk of Eli Lilly
 - Jim Federlein of Bayer Technology Services
 - November 16 – Storage of Other Information in SPI with presentations by:
 - Frank Bielen of Bayer MaterialScience
 - Rick Graham of ExxonMobile

Topics of O/O Member Interest

- SPI Maintenance & Calibration Modules – Who is using? In what capacity? Is the maintenance module sufficient for I&E Maintenance needs? Anyone used the Fluke interface?
- How to police contractors from changing plant standards.
- Internal I.T. SPI System & Admin Support (with SPI expertise) for O/O
- Tips & Tricks for Internal SPI Networks (eg. Citrix)

Topics of O/O Member Interest

cont'd

- Integration with Maintenance Management System(s)
- Integration issues/gaps with other Systems (DCS Systems, Device Network Systems)
- Best Practices for SPI Hierarchy
- How to make SPI information available through other applications (e.g. Documentation, Sharepoint).
- Upgrading (versions, service packs, hot fixes)
- Archiving of revisions.

O/O Committee Next Meeting

- Tuesday, January 18, 2011 from 9 – 11 AM CST via teleconference using Intergraph's facilities.
- Agenda:
 - Data Dictionary use and experience - Rick Graham, ExxonMobile and Greg Brueckner, Bayer Technology Services
 - Creating SRS specification using SPI and ExSilentia data - Bernadette Thornton, Chevron
 - SmartPlant Foundation Capabilities – Intergraph
 - Experiences with Using SPI, SPE, SPEL, SPPID, etc. together - Frank Bielen, Bayer MaterialScience